Form PTO 1449 (Modified)		U.S. DEPARTMENT OF PATENT AND TRADER		ATTY DOCKET	NO. 204842US8	PIENTS	- sew	SERIAL I	vo. 09/809	,074
LIST OF R	REFEF	RENCES CITED BY APPL	ICANT	APPLICANT Shinya NAGAMATSU, et al.						
				FILING DATE	March 16, 2001			GROUP	282	28
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EXAMINER INITIAL	-	DOCUMENT NUMBER	DATE		NAME		CLASS	SUB CLASS	FILING DATE S IF APPROPRIATE	
EAM	AA	4,820,010	4/11/89	Scifres et al.			285	43		
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	AM/	08-116138	5/7/96	Japan w/ Englis	h abstract					×
Dyvy	- <b>A</b> N	09-181376	7/11/97	Japan w/ Englis	h abstract					X
1 9774	ÃO	05-167143	7/2/93	Japan w/ Englis	h abstract					X
BM	ΑP	60-153188	8/12/85	Japan w/ Englis	h abstract					×
PWE	ΑQ	63-302584	12/9/88	Japan w/ Englis	h abstract					Χ.
ENY.	<b>A</b> R	04-179180	6/25/92	Japan w/ Englis	h abstract					×
1 3 W4	AS	10-200208	7/31/98	Japan w/ Englis	h abstract					×
93114	ΑŢ	1209783	5/29/02	Europe (in Engl	ish)					
PML	AU	0268523	5/25/88	Europe (in Engl	ish)					
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OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)										
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*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.										